

# TOSHIBA MOS MEMORY PRODUCTS

2,048 WORD × 8 BIT CMOS STATIC RAM  
SILICON GATE CMOS

TC5516AP/-2, TC5516APL/-2  
TC5516AF/-2, TC5516AFL/-2

## DESCRIPTION

The TC5516AP/AF is a 16384-bit static random access memory organized as 2048 words by 8 bit using CMOS technology, and operates from a single 5 volt supply.

The TC5516AP/AF is featured by two chip enable inputs, that is,  $\overline{CE}_1$  for fast memory access and  $\overline{CE}_2$  for a minimum standby current mode, and is suited for low power application where battery operation or battery back up for nonvolatility are required. Furthermore the TC5516APL/AFL guaranteed a

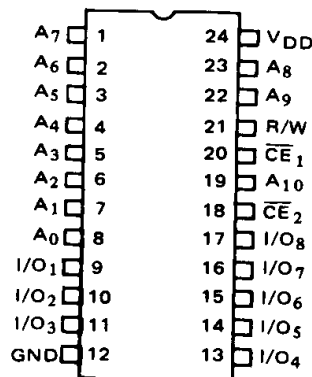
standby current equal to or less than  $1\mu\text{A}$  at  $60^\circ\text{C}$  ambient temperature is available.

The TC5516AP is also featured by pin compatibility with 2716 type EPROM. This means that the TC5516AP and EPROM can be interchanged in the same socket, and the flexibility in the definition of the quantity of RAM versus EPROM obtained as a result allows the wide application in microcomputer system.

## FEATURES

- Standby Current
    - $0.2\mu\text{A}$  (Max.) at  $T_a = 25^\circ\text{C}$
    - $1.0\mu\text{A}$  (Max.) at  $T_a = 60^\circ\text{C}$
 } TC5516APL/AFL
  - $1.0\mu\text{A}$  (Max.) at  $T_a = 25^\circ\text{C}$
  - $5.0\mu\text{A}$  (Max.) at  $T_a = 60^\circ\text{C}$
- } TC5516AP/AF
- Low Power Dissipation : 200mW (Typ.)  
Operating
- Single 5V Power Supply :  $5\text{V} \pm 10\%$
- Data Retention Supply Voltage: 2.0 ~ 5.5V
- Fully Static Operation
- Access Time
  - 250ns (Max.): TC5516AP/APL/AF/AFL
  - 200ns (Max.): TC5516AP-2/APL-2/AF-2/AFL-2
- Two Chip Enable ( $\overline{CE}_1$ ,  $\overline{CE}_2$ ) for Simple Memory Expansion and Battery Back Up.
- All Inputs and Outputs Directly TTL Compatible
- Three State Outputs
- Package
  - Plastic DIP : TC5516AP/APL
  - Plastic FP : TC5516AF/AFL

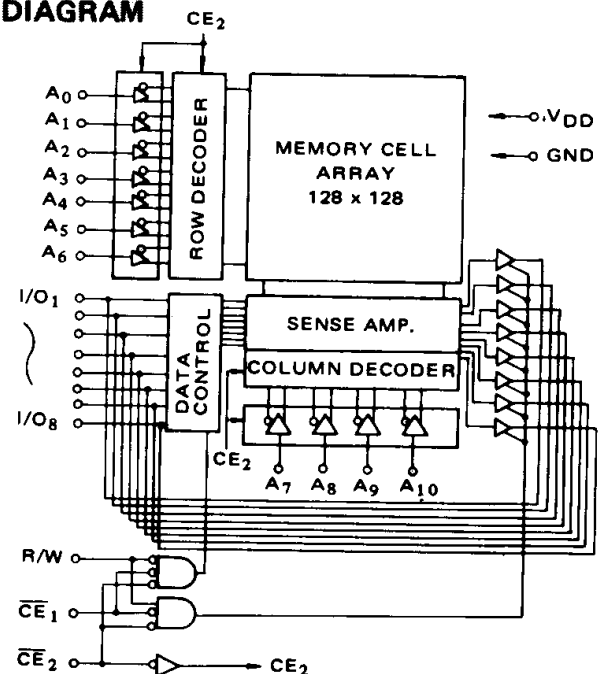
## PIN CONNECTION (TOP VIEW)



## PIN NAMES

|                                    |                          |
|------------------------------------|--------------------------|
| $A_0 \sim A_{10}$                  | Address Inputs           |
| R/W                                | Read/Write Control Input |
| $\overline{CE}_1, \overline{CE}_2$ | Chip Enable Inputs       |
| $I/O_1 \sim I/O_8$                 | Data Input/Output        |
| $V_{DD}$                           | Power (+5V)              |
| GND                                | Ground                   |

## BLOCK DIAGRAM



# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

## ABSOLUTE MAXIMUM RATINGS

| SYMBOL              | ITEM                                      | RATING                        |
|---------------------|-------------------------------------------|-------------------------------|
| V <sub>DD</sub>     | Power Supply Voltage                      | -0.3V ~ 7.0V                  |
| V <sub>IN</sub>     | Input Voltage                             | -0.3V ~ V <sub>DD</sub> + 0.3 |
| V <sub>I/O</sub>    | Input/Output Voltage                      | -0.3V ~ V <sub>DD</sub> + 0.3 |
| P <sub>D</sub>      | Power Dissipation (T <sub>a</sub> = 85°C) | 0.8W (0.45W)*                 |
| T <sub>STG</sub>    | Storage Temperature                       | -55°C ~ 150°C                 |
| T <sub>OPR</sub>    | Operating Temperature                     | -30°C ~ 85°C                  |
| T <sub>SOLDER</sub> | Soldering Temperature · Time              | 260°C · 10 sec                |

\*Plastic FP

## RECOMMENDED D.C. OPERATING CONDITIONS (T<sub>a</sub> = -30 ~ 85°C)

| SYMBOL          | PARAMETER              | MIN. | TYP. | MAX.                  | UNIT |
|-----------------|------------------------|------|------|-----------------------|------|
| V <sub>DD</sub> | Power Supply Voltage   | 4.5  | 5.0  | 5.5                   | V    |
| V <sub>IH</sub> | Input High Voltage     | 2.2  | —    | V <sub>DD</sub> + 0.3 | V    |
| V <sub>IL</sub> | Input Low Voltage      | -0.3 | —    | 0.8                   | V    |
| V <sub>DH</sub> | Data Retention Voltage | 2.0  | —    | 5.5                   | V    |

## D.C. CHARACTERISTICS (T<sub>a</sub> = -30 ~ 85°C, V<sub>DD</sub> = 5V ± 10%)

| SYMBOL                                 | PARAMETER             | CONDITIONS                                                                                        |                   | MIN.                  | TYP. | MAX.  | UNIT |    |
|----------------------------------------|-----------------------|---------------------------------------------------------------------------------------------------|-------------------|-----------------------|------|-------|------|----|
| I <sub>IL</sub>                        | Input Leakage Current | 0 ≤ V <sub>IN</sub> ≤ V <sub>DD</sub>                                                             |                   | —                     | —    | ±1.0  | μA   |    |
| I <sub>LO</sub>                        | I/O Leakage Current   | CE <sub>2</sub> = V <sub>IH</sub> , 0V ≤ V <sub>I/O</sub> ≤ V <sub>DD</sub>                       |                   | —                     | —    | ±5.0  | μA   |    |
| I <sub>OH</sub>                        | Output High Current   | V <sub>OH</sub> = 2.4V                                                                            |                   | -1.0                  | -2.0 | —     | mA   |    |
| I <sub>OL</sub>                        | Output Low Current    | V <sub>OL</sub> = 0.4V                                                                            |                   | 2.0                   | 3.0  | —     | mA   |    |
| I <sub>DDS1</sub>                      | Standby Current       | CE <sub>2</sub> = 2.2V                                                                            |                   | —                     | 1.0  | 3.0   | mA   |    |
| I <sub>DDS2</sub>                      |                       | CE <sub>2</sub> = V <sub>DD</sub> - 0.5V                                                          | TC5516APL/<br>AFL | T <sub>a</sub> = 25°C | —    | 0.005 | 0.2  | μA |
|                                        |                       |                                                                                                   |                   | T <sub>a</sub> = 60°C | —    | —     | 1.0  |    |
|                                        |                       | V <sub>DD</sub> = 2 ~ 5.5V                                                                        | TC5516AP/<br>AF   | T <sub>a</sub> = 25°C | —    | 0.05  | 1.0  |    |
| T <sub>a</sub> = 60°C                  | —                     |                                                                                                   |                   | —                     | 5.0  |       |      |    |
| I <sub>DDO1</sub><br>I <sub>DDO2</sub> | Operating Current     | CE <sub>2</sub> = 0V, V <sub>IN</sub> = V <sub>IH</sub> /V <sub>IL</sub> , I <sub>OUT</sub> = 0mA |                   | —                     | 40   | 70    | mA   |    |
|                                        |                       | CE <sub>2</sub> = 0V, V <sub>IN</sub> = V <sub>DD</sub> /GND, I <sub>OUT</sub> = 0mA              |                   | —                     | 30   | 55    |      |    |

Note: Typical values are at T<sub>a</sub> = 25°C, V<sub>DD</sub> = 5V.

## CAPACITANCE

| SYMBOL           | PARAMETER                | MIN. | TYP. | MAX. | UNIT |
|------------------|--------------------------|------|------|------|------|
| C <sub>IN</sub>  | Input Capacitance        | —    | 5    | 10   | pF   |
| C <sub>I/O</sub> | Input/Output Capacitance | —    | 5    | 10   | pF   |

Note: This parameter is periodically sampled and is not 100% tested.

# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

## A.C. CHARACTERISTICS (Ta = -30 ~ 85°C, VDD = 5V ± 10%)

### • Read Cycle

| SYMBOL           | PARAMETER                                               | TC5516AP-2/APL-2<br>TC5516AF-2/AFL-2 |      | TC5516AP/APL<br>TC5516AF/AFL |      | UNIT |
|------------------|---------------------------------------------------------|--------------------------------------|------|------------------------------|------|------|
|                  |                                                         | MIN.                                 | MAX. | MIN.                         | MAX. |      |
| t <sub>RC</sub>  | Read Cycle Time                                         | 200                                  | —    | 250                          | —    | ns   |
| t <sub>ACC</sub> | Access Time                                             | —                                    | 200  | —                            | 250  | ns   |
| t <sub>CO1</sub> | $\overline{CE}_1$ to Output Valid                       | —                                    | 100  | —                            | 100  | ns   |
| t <sub>CO2</sub> | $\overline{CE}_2$ to Output Valid                       | —                                    | 200  | —                            | 250  | ns   |
| t <sub>COE</sub> | $\overline{CE}_1$ or $\overline{CE}_2$ to Output Active | 10                                   | —    | 10                           | —    | ns   |
| t <sub>OD</sub>  | Output High-Z form Deselection                          | —                                    | 80   | —                            | 80   | ns   |
| t <sub>OH</sub>  | Output Hold from Address Change                         | 10                                   | —    | 10                           | —    | ns   |

### • Write Cycle

| SYMBOL           | PARAMETER              | TC5516AP-2/APL-2<br>TC5516AF-2/AFL-2 |      | TC5516AP/APL<br>TC5516AF/AFL |      | UNIT |
|------------------|------------------------|--------------------------------------|------|------------------------------|------|------|
|                  |                        | MIN.                                 | MAX. | MIN.                         | MAX. |      |
| t <sub>WC</sub>  | Write Cycle Time       | 200                                  | —    | 250                          | —    | ns   |
| t <sub>WP</sub>  | Write Pulse Width      | 160                                  | —    | 200                          | —    | ns   |
| t <sub>AW</sub>  | Address Set Up Time    | 0                                    | —    | 0                            | —    | ns   |
| t <sub>WR</sub>  | Write Recovery Time    | 10                                   | —    | 10                           | —    | ns   |
| t <sub>ODW</sub> | Output High-Z from R/W | —                                    | 80   | —                            | 80   | ns   |
| t <sub>OEW</sub> | Output Active from R/W | 10                                   | —    | 10                           | —    | ns   |
| t <sub>DS</sub>  | Data Set Up Time       | 80                                   | —    | 120                          | —    | ns   |
| t <sub>DH</sub>  | Data Hold Time         | 0                                    | —    | 0                            | —    | ns   |

## A.C. TEST CONDITIONS

Output Load : 100 pF + ITTL Gate

Input Pulse Levels : 0.6V, 2.4V

Timing Measurement Reference Levels

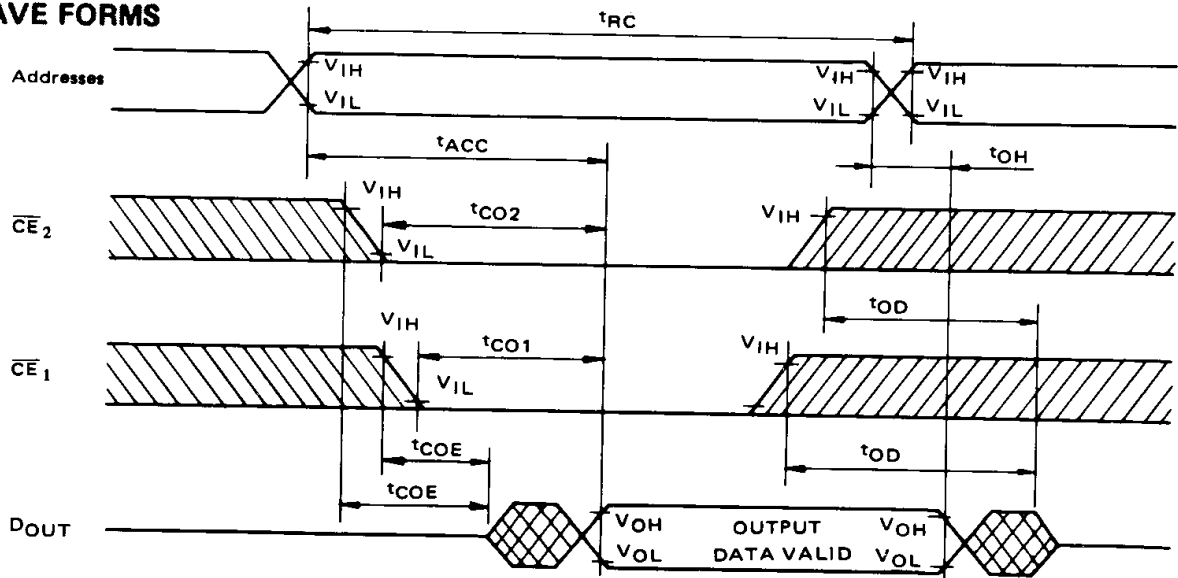
Input : 0.8V and 2.2V

Output : 0.8V and 2.2V

Input Pulse Rise and Fall Times : 10ns

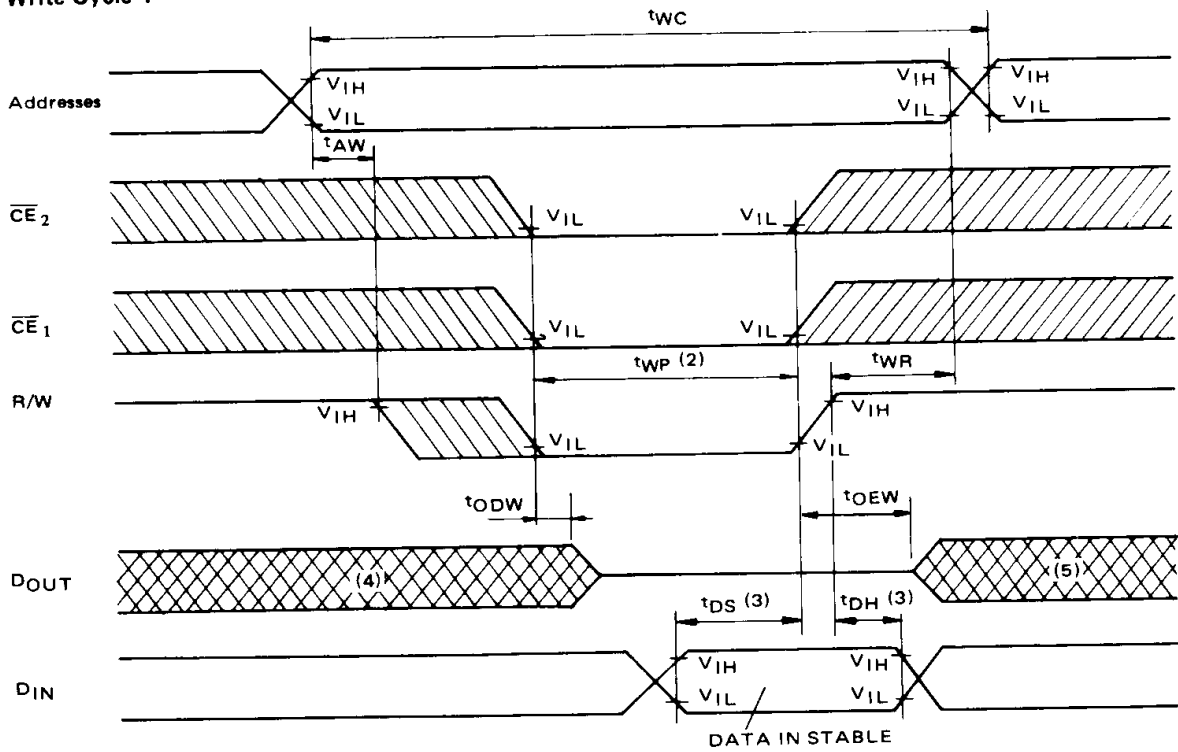
## TIMING WAVE FORMS

### • Read Cycle

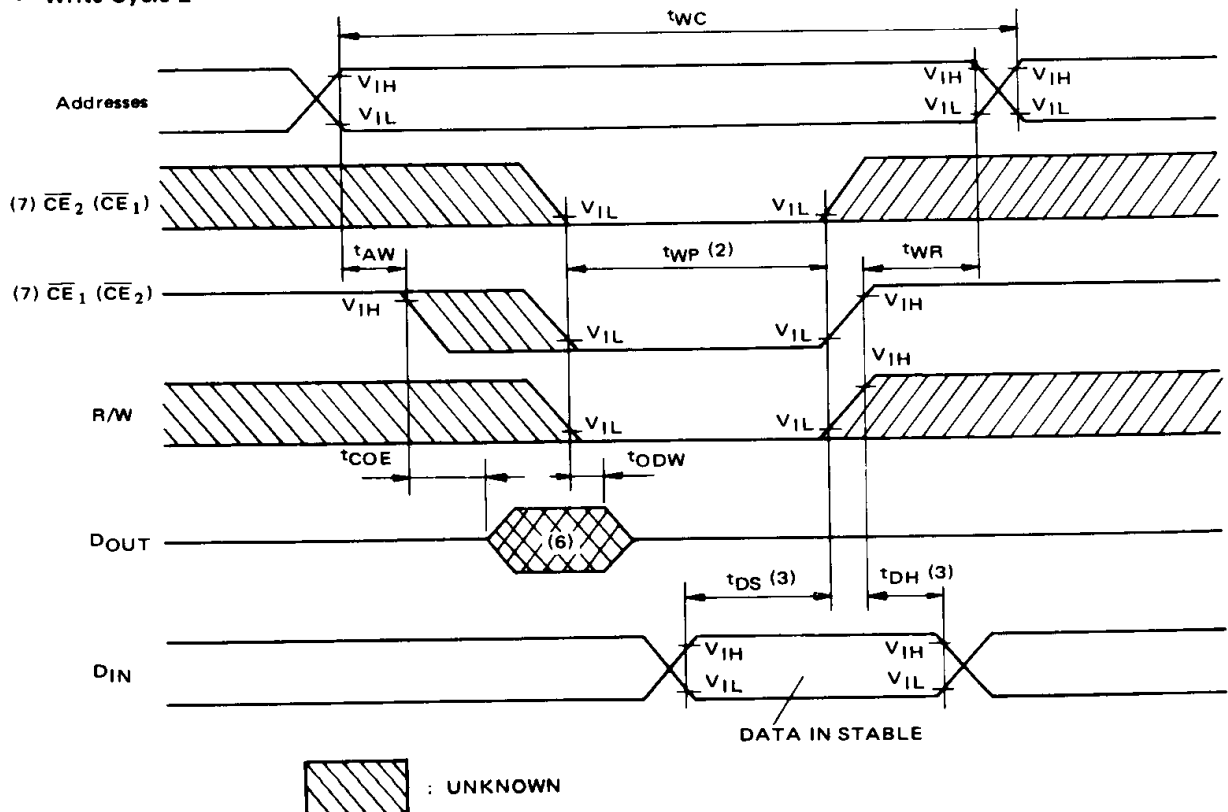


# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

## ● Write Cycle 1



## ● Write Cycle 2



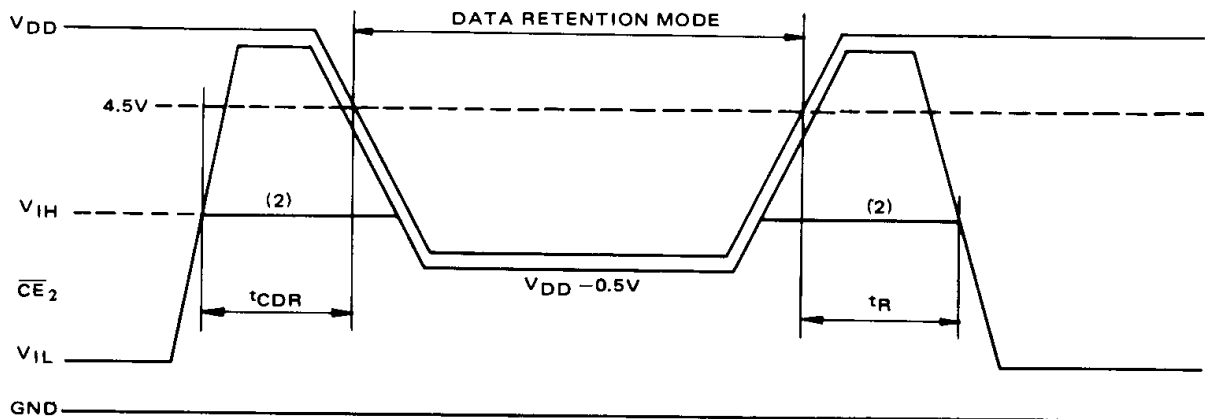
# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

- NOTE: (1) R/W is high for a Read Cycle.  
 (2)  $t_{WP}$  is specified as the logical "AND" of  $\overline{CE}_1$ ,  $\overline{CE}_2$  and R/W.  
 $t_{WP}$  is measured from the latter of  $\overline{CE}_1$ ,  $\overline{CE}_2$  or R/W going low to the earlier of  $\overline{CE}_1$ ,  $\overline{CE}_2$  or R/W going high.  
 (3)  $t_{DH}$ ,  $t_{DS}$  are measured from the earlier of  $\overline{CE}_1$ ,  $\overline{CE}_2$  or R/W going high.  
 (4) If the  $\overline{CE}_1$ , or  $\overline{CE}_2$  low transition occurs simultaneously with or latter from the R/W low transition in a Write Cycle 1, the output buffers remain in a high impedance state in this period.  
 (5) If the  $\overline{CE}_1$  or  $\overline{CE}_2$  high transition occurs prior to or simultaneously with the R/W high transition in a Write Cycle 1, the output buffers remain in a high impedance state in this period.  
 (6) If the R/W is low or the R/W low transition occurs prior to or simultaneously with the  $\overline{CE}_1$  or  $\overline{CE}_2$  low transition, the output buffers remain in a high impedance state in this period.  
 (7) A write occurs during the overlap of a low  $\overline{CE}_1$ , low  $\overline{CE}_2$  and low R/W. In write cycle 2, write is controlled by either  $\overline{CE}_1$  or  $\overline{CE}_2$ .

## DATA RETENTION CHARACTERISTICS ( $T_a = -30 \sim 85^\circ\text{C}$ )

| SYMBOL     | PARAMETER                                    | MIN.              | TYP.                     | MAX. | UNIT          |               |     |
|------------|----------------------------------------------|-------------------|--------------------------|------|---------------|---------------|-----|
| $V_{DH}$   | Data Retention Power Supply Voltage          | 2.0               | —                        | 5.5  | V             |               |     |
| $I_{DDS2}$ | Standby Current                              | TC5516APL/<br>AFL | $T_a = 25^\circ\text{C}$ | —    | 0.005         | $\mu\text{A}$ |     |
|            |                                              |                   | $T_a = 60^\circ\text{C}$ | —    | —             |               | 1.0 |
|            |                                              | TC5516AP/<br>AF   | $T_a = 25^\circ\text{C}$ | —    | 0.05          |               | 1.0 |
|            |                                              |                   | $T_a = 60^\circ\text{C}$ | —    | —             |               | 5.0 |
| $t_{CDR}$  | From Chip Deselection to Data Retention Mode | 0                 | —                        | —    | $\mu\text{s}$ |               |     |
| $t_R$      | Recover Time                                 | $t_{RC}$ (1)      | —                        | —    | $\mu\text{s}$ |               |     |

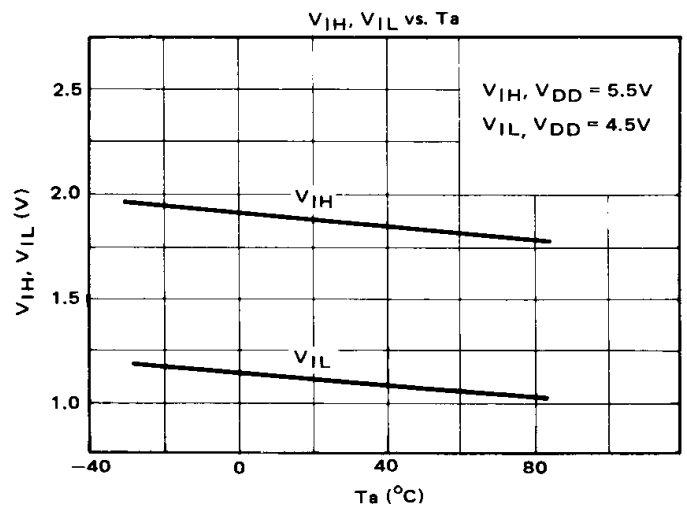
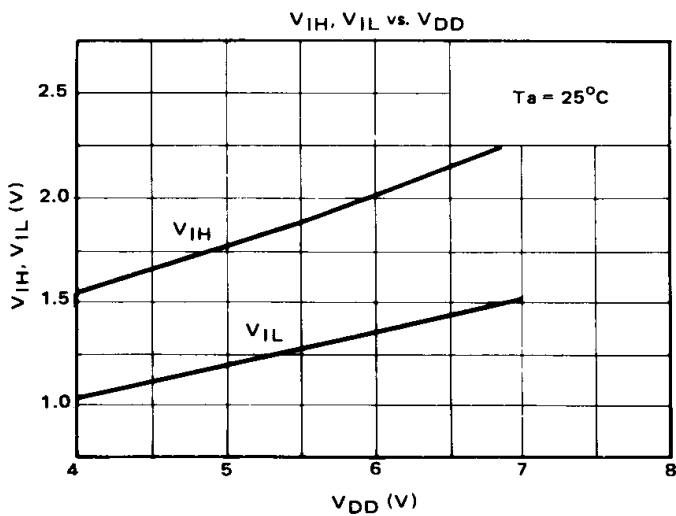
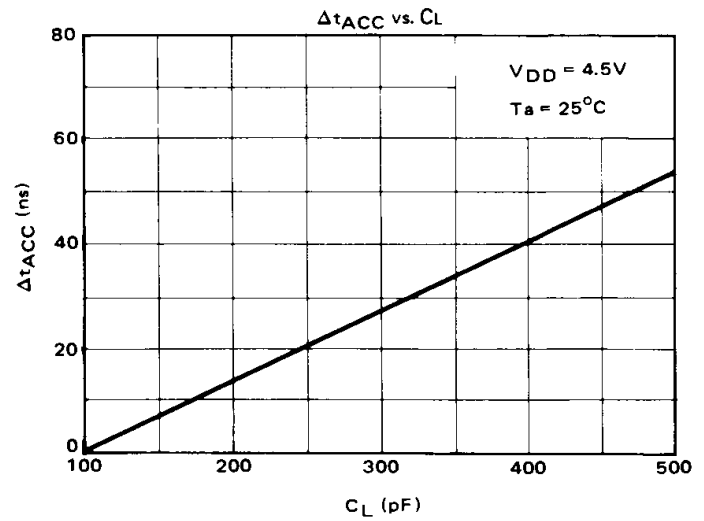
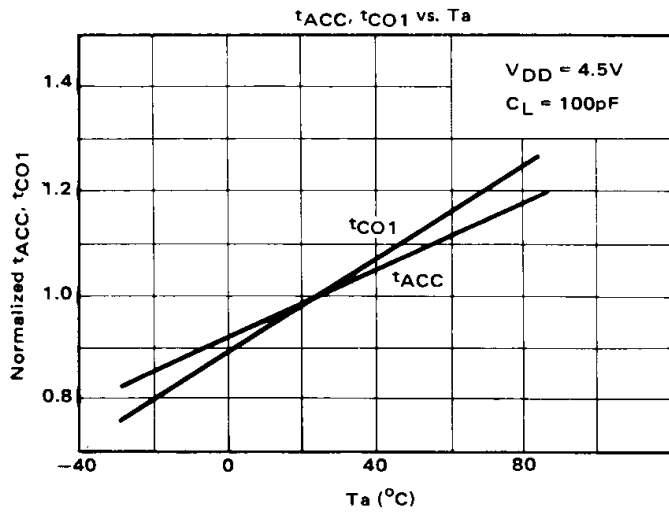
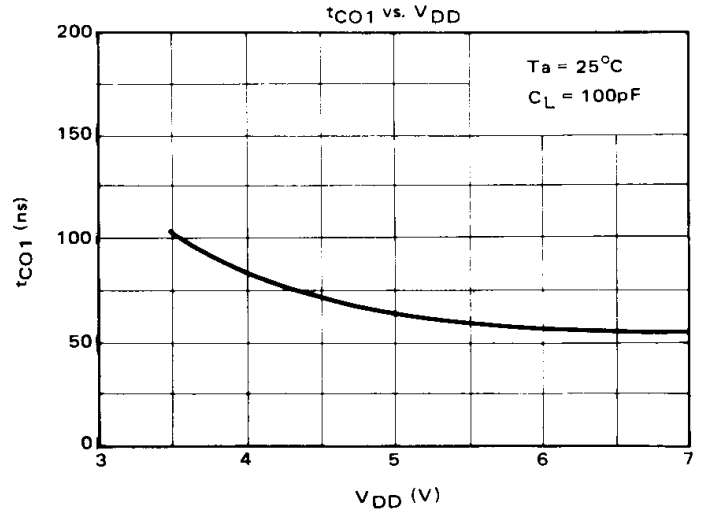
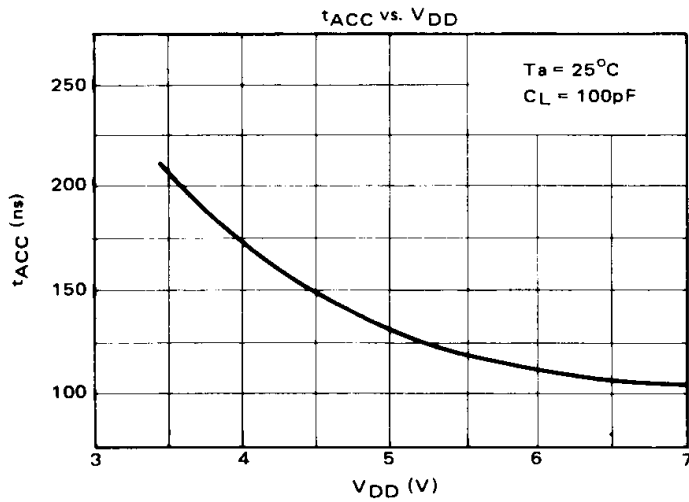
Note (1)  $t_{RC}$  : Read Cycle Time.



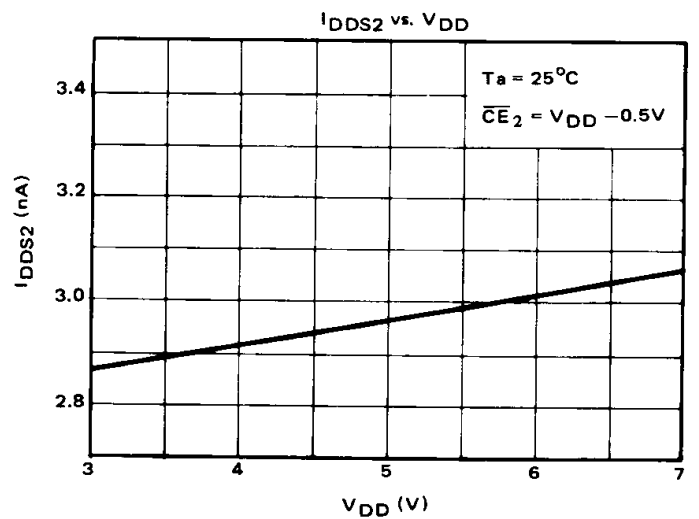
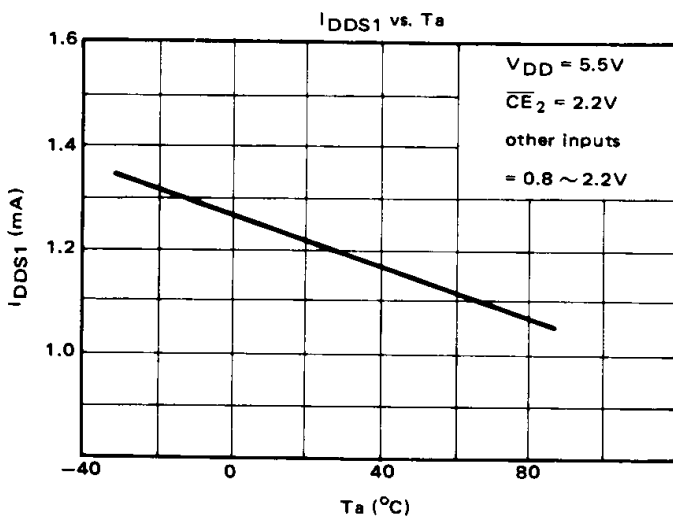
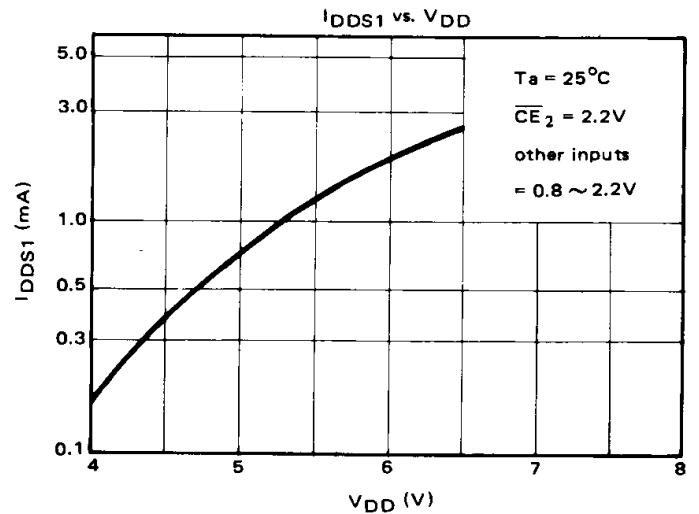
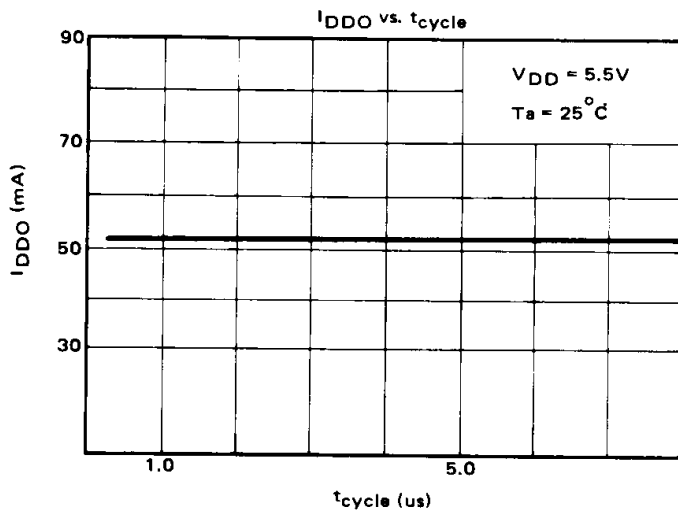
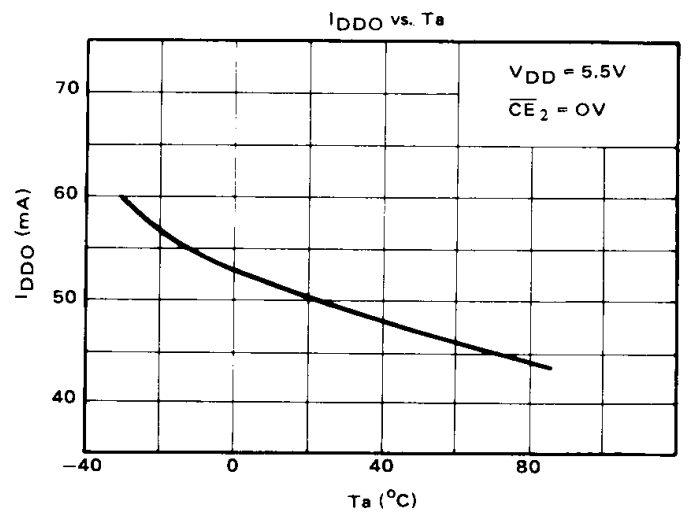
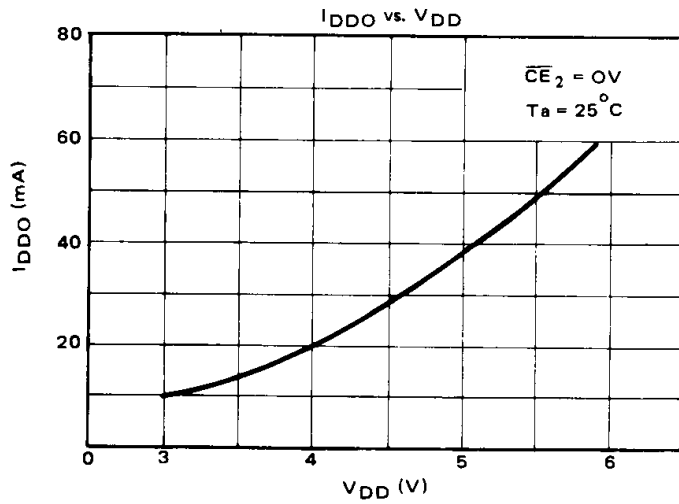
Note: (2) If the  $V_{IH}$  level of  $\overline{CE}_2$  is 2.2V, during the period that the  $V_{DD}$  voltage is going down from 4.5V to 2.7V,  $I_{SSD1}$  current flows. (Refer to D.C. CHARACTERISTICS or TYPICAL CHARACTERISTIC FIGURES.)

# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

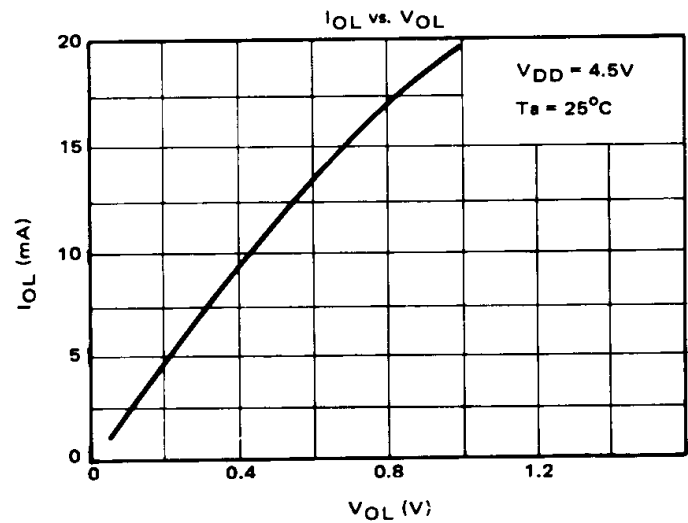
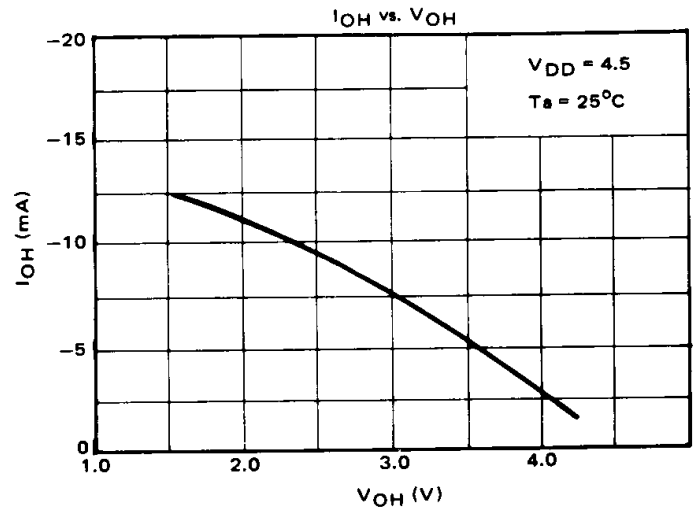
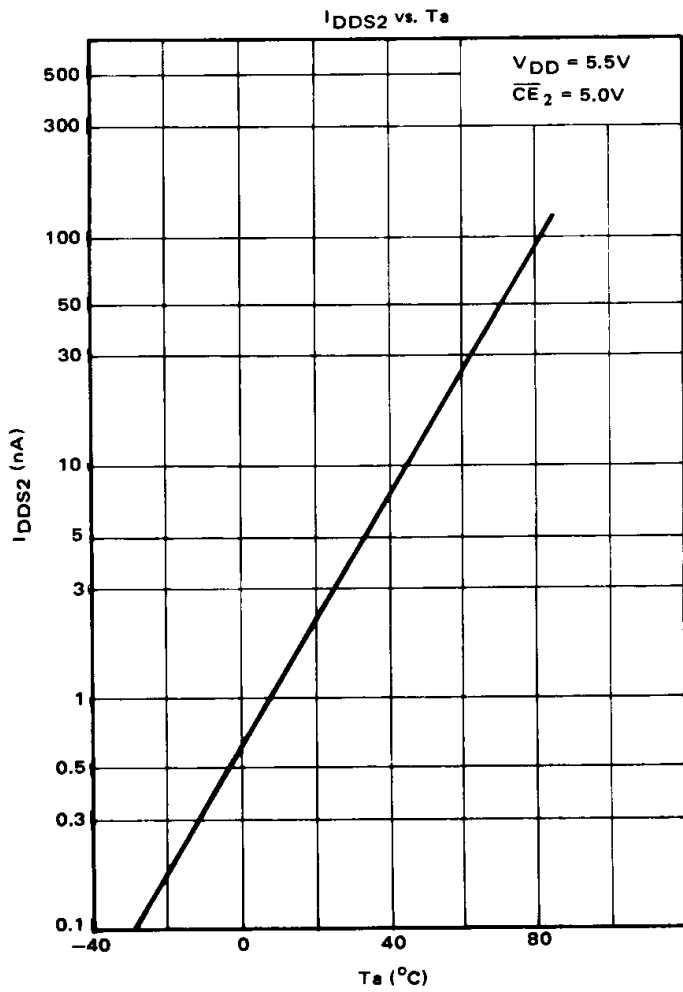
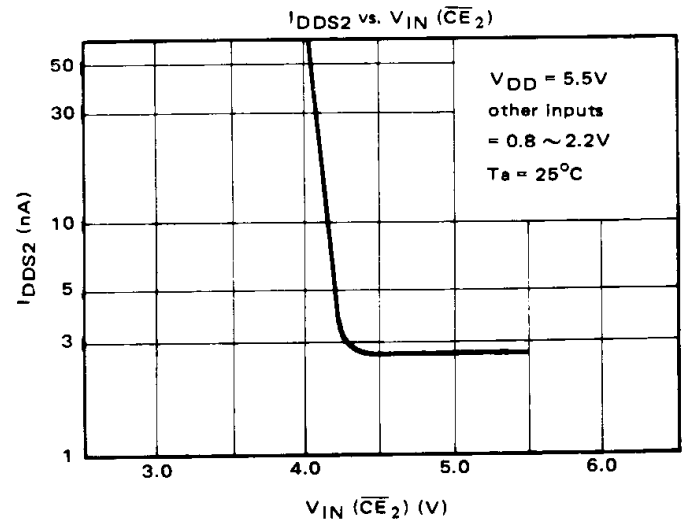
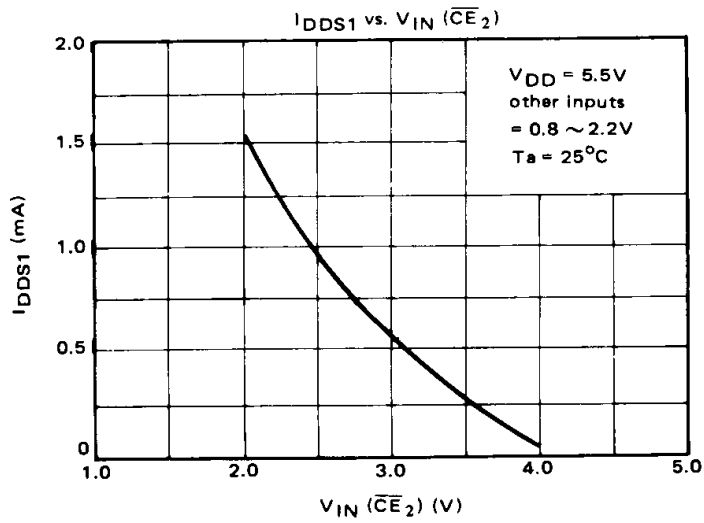
## TYPICAL CHARACTERISTICS



# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2



# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

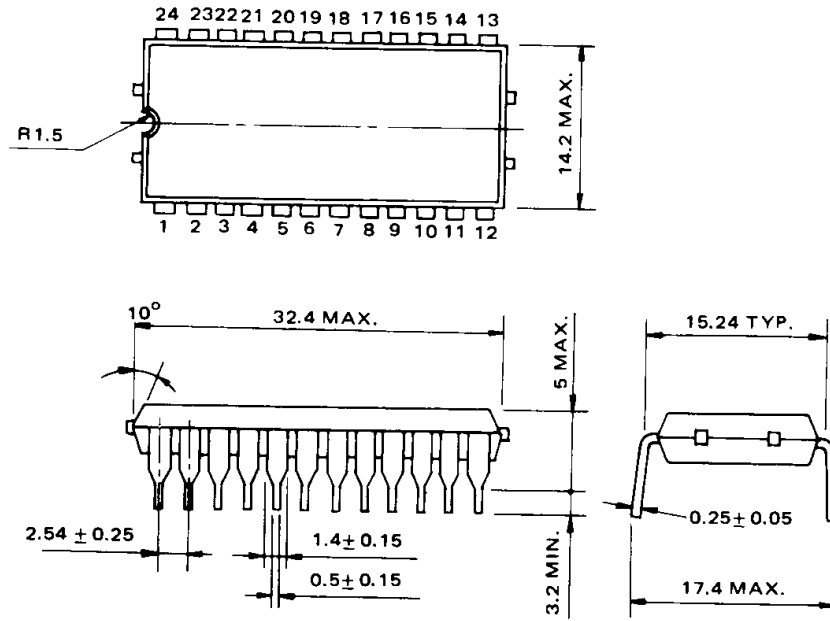




# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

## OUTLINE DRAWINGS

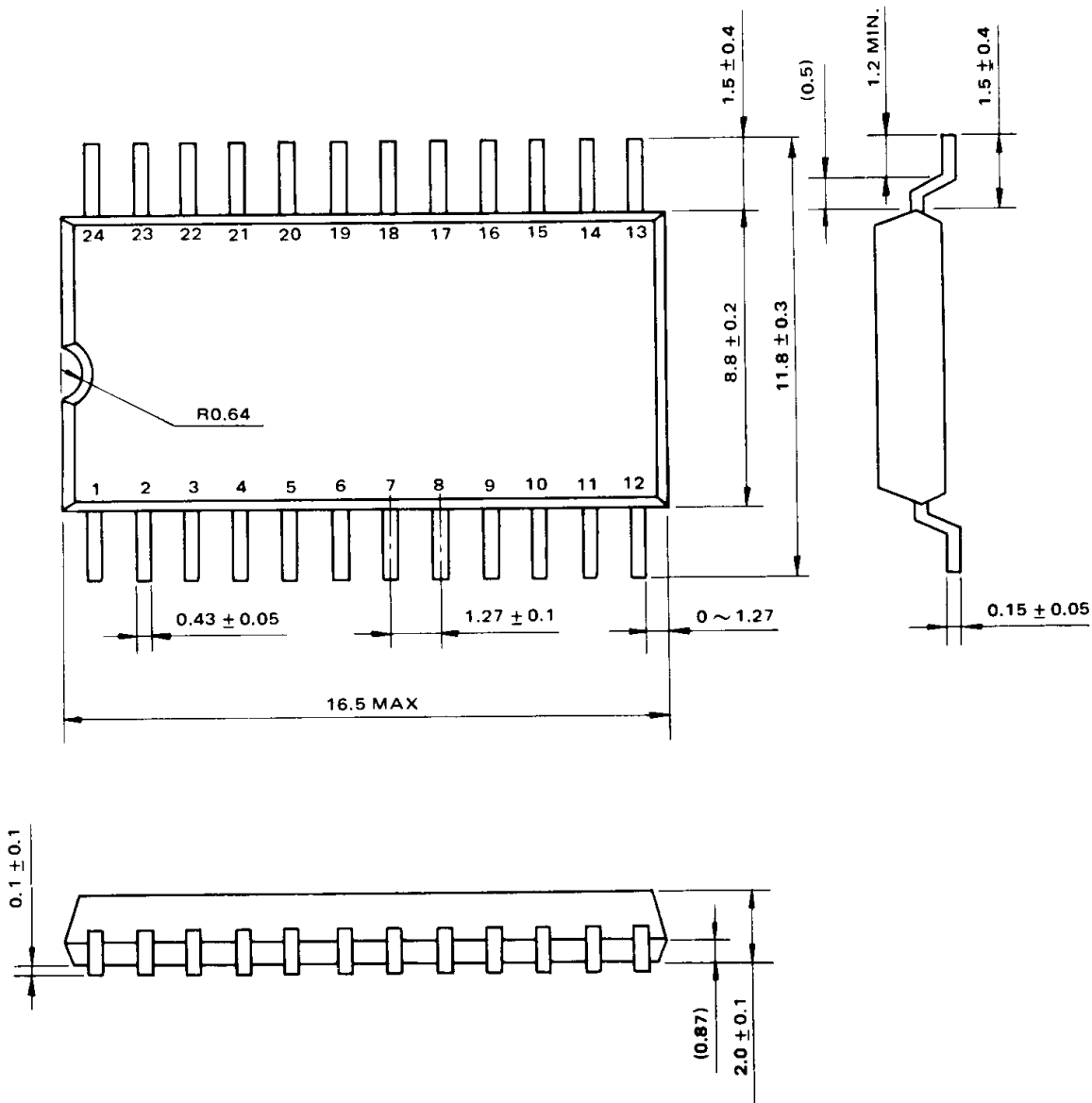
- Plastic DIP



Note : Each lead pitch is  $2.54 \text{ mm}$ . All leads are located within  $0.25 \text{ mm}$  of their true longitudinal position with respect to No. 1 and No. 24 leads.  
All dimensions are in millimeters.

# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

- Plastic FP



Note : Each lead pitch is 1.27mm. All leads are located within 0.1mm of their true longitudinal position with respect to No.1 and No.24 leads.

# TC5516AP/-2, TC5516APL/-2 TC5516AF/-2, TC5516AFL/-2

## PACKAGE INFORMATION FOR FLAT PACKAGE

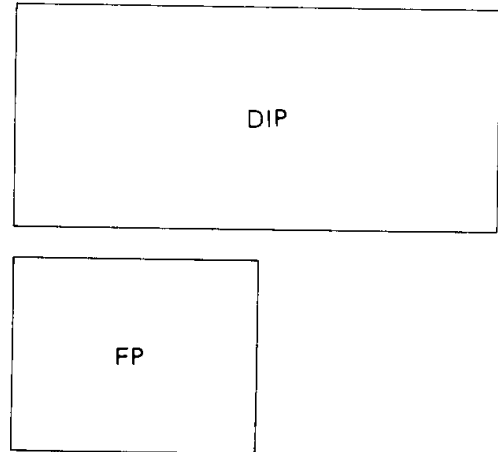
This new flat package is a very small and thin compared with conventional standard dual-in-line package. Differences are as follows.

1. Difference in dimension between flat and standard package.

Unit : mm

|            | Flat package | Standard package |
|------------|--------------|------------------|
| Length     | 16.5         | 32.4             |
| Width      | 9.0          | 14.2             |
| Lead Pitch | 1.27         | 2.54             |
| Thickness  | 2.1          | 5                |

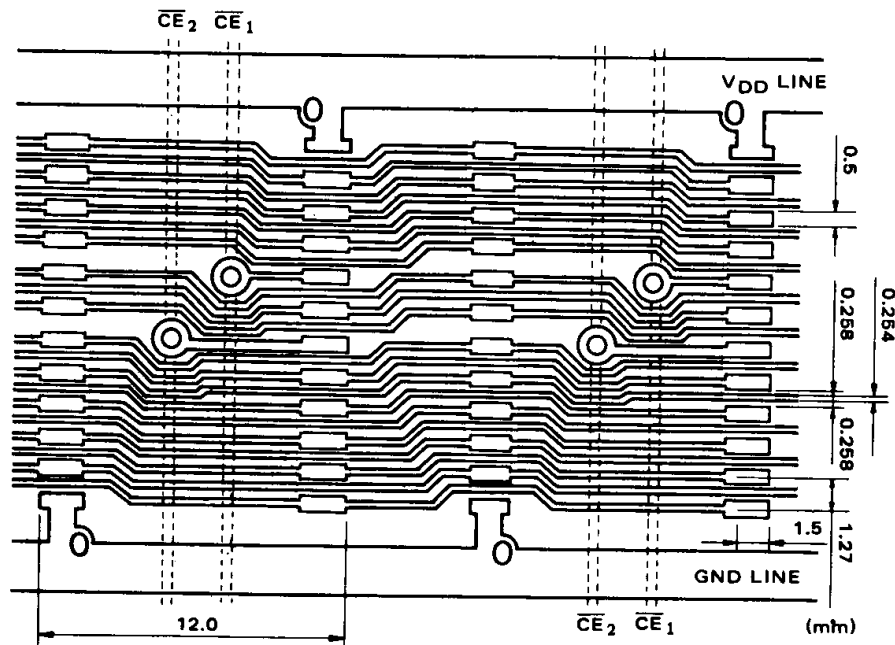
2. Comparison in occupied space.



3. Advantage of this package

- Small dimensions
- Capability of High Density Assembly
- Capability of thin Assembly — Capability of Assembly on both side of PC board.

4. PC pattern layout example



**TC5516AP/-2, TC5516APL/-2  
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**Note:** Toshiba does not assume any responsibility for use of any circuitry described; no circuit patent licenses are implied, and Toshiba reserves the right, at any time without notice, to change said circuitry.

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